BCA INDUSTRIAL GROUP AUTUMN MEETINGS

Pharmaceutical SIG - 7th Nov 2007

09:15 REGISTRATION, COFFEE & PASTRIES.

Chair: Anne Kavanagh.

09:45 WELCOME.

09:50 Roger Davey

Polymorphism in molecular crystals - how much have we learnt?

10:25 Gordon Barr (for Chris Gilmore)

Is PXRD the Gold Standard in High Throughput Experiments?

11:00 COFFEE

11:25 Tal Austin

Understanding relative polymorph stability through structure and thermodynamics

12:00 Bill Jones

Screening for New Crystal Forms Based on Mechanical Activation of Mixtures

12:35 Jerry Heng

Crystal Engineering: The Importance of Surface Properties

13:10 LUNCH

Chair: Roy Copley.

13:55 Fred Vogt

X-ray Diffraction, Computational Chemistry and Solid-state NMR: A Multi-disciplinary Approach to Understanding the Pharmaceutical Solid-state

14:30 Jonathan Burley

Cocrystals and Other Complex Pharmaceutical Materials: Structure Solution from Powder Diffraction

15:05 COFFEE

15:30 Jacco van de Streek

Semi-automated Rietveld Refinement of Molecular Crystal Structures with DASH & TOPAS

16:05 Maryjane Tremayne

Powders and 'Peer-Pressure': Pitfalls and Progress

16:40 CLOSE

Local organiser:

Dr Anne Kavanagh, Tel:01625 517454 Email: IGChair.BCA@googlemail.com

Autumn Meeting - 8th November 2007

Morning Session - Rietveld applications. 09:15 REGISTRATION. COFFEE & PASTRIES.

Chair: Steve Norval.

09:45 WELCOME.

09:50 Jeremy K. Cockcroft, University College London

Rietveld: Pitfalls for the non-Expert.

10:30 Tony Bell, Daresbury Laboratory

Time Resolved Synchrotron X-ray Powder Diffraction Study of Biogenic

Nano-Magnetite. **11:00 COFFEE**

Chair: Jeremy K. Cockcroft.

11:30 Steve Norval, Intertek MSG.

Versatile Rietveld - Applications to Real Materials.

12:00 Michela Brunelli, ESRF, Grenoble.

Rietveld Refinement of organic molecules: investigation of hydrogen-bond patterns

12:30 Stuart Turner, Crystallography, Birkbeck College.

Rietveld Fitting of High-throughput Data.

13:00 LUNCH

Afternoon Session - Crystallography in Industry Chair: *Judith Shackleton*.

13:50 Moataz Attallah, Materials Science Centre, Univ of Manchester Utilising energy dispersive synchrotron X-ray diffraction for characterising stresses in two-phase titanium linear friction welds.

14:20 Ian F. Ferguson, UKAEA, retired.

Inverse pole figures, their application to a detailed understanding of XRPD measurements.

14:50 Andrew Winn, Manchester Materials Science Centre.

Industrial Applications of Residual Stress Measurement using XRD.

15:20 COFFEE

15:40 Robert Hammond, University of Leeds.

Application of X-Ray Diffraction In-line to Monitor Solution Mediated Phase Transformations between Polymorphs During Batch Crystallization Processes.

16:10 James Chisholm, Cambridge Crystallographic Data Centre. Analysis of Polymorphic Forms - Understanding and Quantifying Packing Similarity.

16:40 CLOSE.